Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/584,952	NAKAZATO ET	AL.
Examiner	Art Unit	
Erich A. Leeser	1624	

SEARCHED				
Class	Subclass	Date	Examiner	
			=	
	,		,	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
with search	50, 514/267 terms, see tout	8/2/2007	EL

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
•	DATE	EXMR
PALM inventor search	8/2/2007	EL
STN structure search	8/2/2007	EL
EAST 544/250, 514/267 with search terms, see printout	8/2/2007	EL
		•